

**Search Notes**

Application/Control No.

10/766,170

Examiner

Thinh T. Nguyen

Applicant(s)/Patent under  
Reexamination

YOSHITOMI ET AL.

Art Unit

2818

**SEARCHED**

Class	Subclass	Date	Examiner
257	40	11/29/2005	TTN
257	13	11/29/2005	TTN
257	22	11/30/2005	TTN

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
EAST	PUB	11/30/2005	TTN

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	11/29/2005	TTN
EAST	11/30/2005	TTN